### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	2.75	
Junction-to-TAB (Drain)	$R_{\thetaJC-TAB}$	3.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\thetaJA}$	57	0/00
Junction-to-Ambient - Steady State (Note 2)	$R_{\thetaJA}$	107	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				27		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ , $T_{J} = 25 °C$				1	
		$V_{DS} = 24 V$ T <sub>J</sub>	T <sub>J</sub> = 125°C			μA 10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 to 11.5 V	I <sub>D</sub> = 30 A		6.7	8.0	
			I <sub>D</sub> = 15 A		6.6		mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		10.3	12.4	
			l <sub>D</sub> = 15 A		9.8		
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			11.4		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 12 V			1538		
Output Capacitance	C <sub>OSS</sub>				334		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				180		1

Reverse Transfer Capacitance	C <sub>RSS</sub>		180		
Total Gate Charge	Q <sub>G(TOT)</sub>		11.3	13	
Threshold Gate Charge	Q <sub>G(TH)</sub>		1.6		nC
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A	4.9		nc
Gate-to-Drain Charge	Q <sub>GD</sub>		4.9		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V; I <sub>D</sub> = 30 A	26		nC

### SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A,	12.3	
Rise Time	t <sub>r</sub>		21.3	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_G = 3.0 \ \Omega$	14.6	ns
Fall Time	t <sub>f</sub>		6.0	

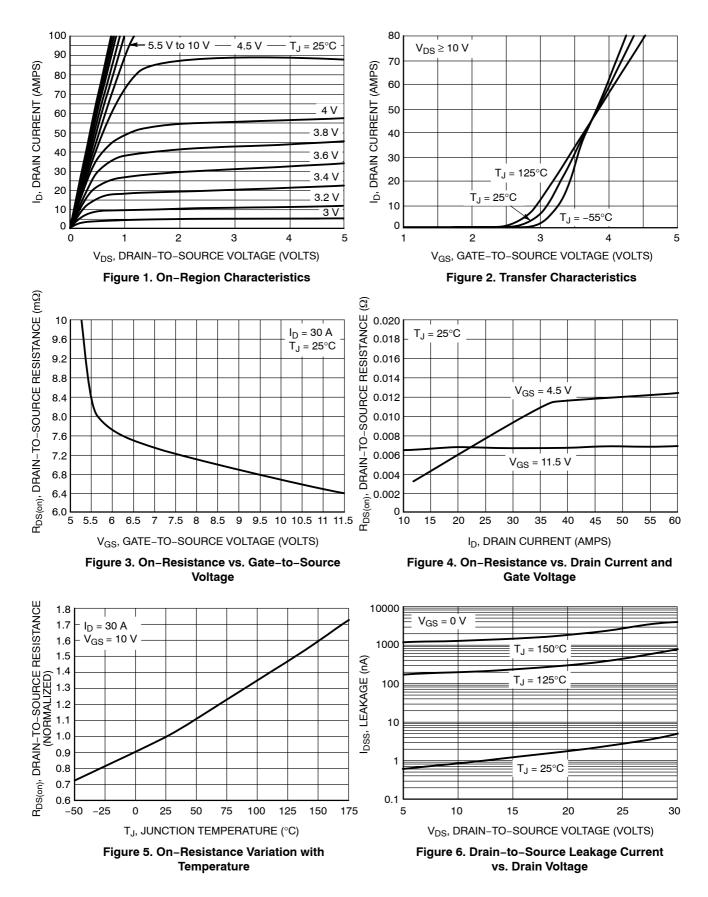
3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

4. Switching characteristics are independent of operating junction temperatures.

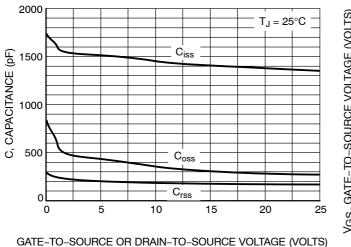
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (M	lote 4)	•					
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 $\Omega$			7.7		
Rise Time	t <sub>r</sub>				19.5		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				23		
Fall Time	t <sub>f</sub>				3.5		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, \\ I_{S} = 30 A \\ T_{J} = 125^{\circ}C \\ T_{J} = 125^{\circ}C$	$T_J = 25^{\circ}C$		0.93	1.2	v
			T <sub>J</sub> = 125°C		0.83		v
Reverse Recovery Time	t <sub>RR</sub>				20		
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt	= 100 A/μs,		10.4		ns
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, dI <sub>S</sub> /dt = 100 A/µs, I <sub>S</sub> = 30 A			9.6		
Reverse Recovery Charge	Q <sub>RR</sub>				9.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			2.49		nH
Drain Inductance, DPAK	L <sub>D</sub>				0.0164		
Drain Inductance, IPAK	L <sub>D</sub>				1.88		
Gate Inductance	L <sub>G</sub>				3.46		
Gate Resistance	R <sub>G</sub>				1.1		Ω

## **TYPICAL PERFORMANCE CURVES**



## **TYPICAL PERFORMANCE CURVES**





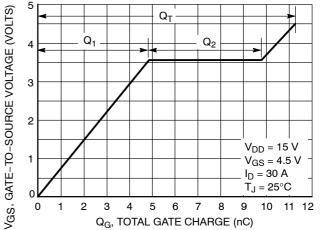
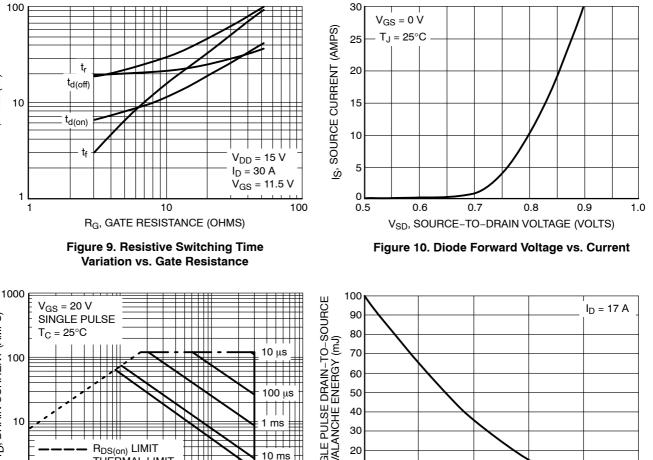
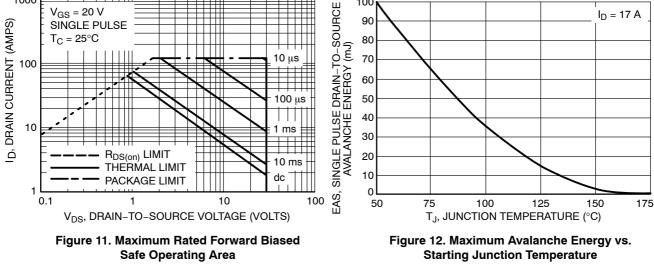


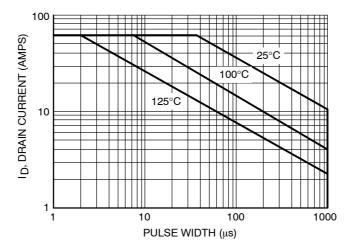
Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



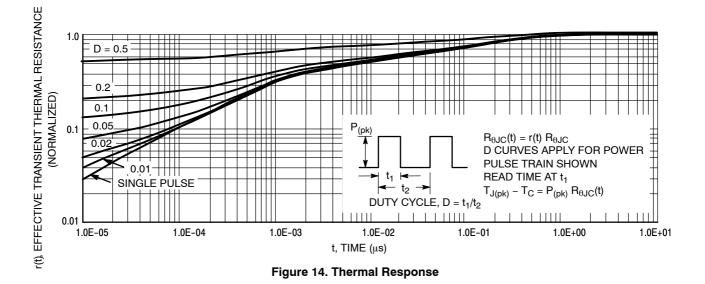


t, TIME (ns)

## **TYPICAL PERFORMANCE CURVES**







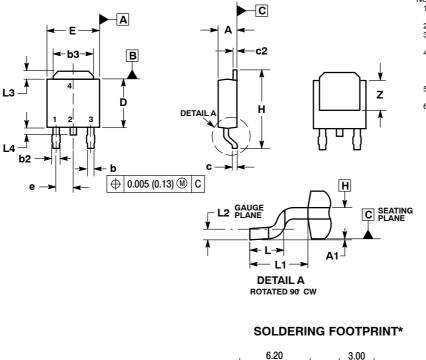
### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTD4808NT4G	DPAK (Pb–Free)	2500 / Tape & Reel
NTD4808N-1G	IPAK (Pb–Free)	75 Units / Rail
NTD4808N-35G	IPAK Trimmed Lead $(3.5 \pm 0.15 \text{ mm})$ (Pb-Free)	75 Units / Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS

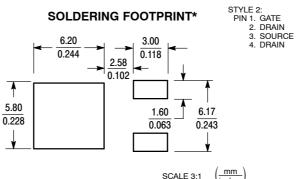
**DPAK (SINGLE GUAGE)** CASE 369AA-01 **ISSUE B** 



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME
- DIMENSIONING AND TOLEHANCING PEH ASME Y14.5M, 1994.
   CONTROLLING DIMENSION: INCHES.
   THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
   DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
   DIMENSIONE ON DE ADD ECTETERMINED AT THE DIMENSIONE DAND E ADD ECTETERMINED AT THE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020	BSC	0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	



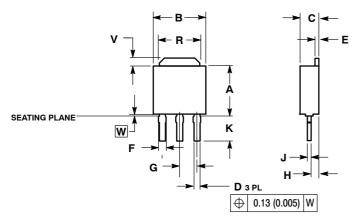
 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

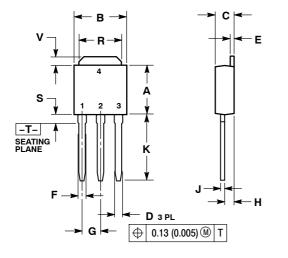
#### PACKAGE DIMENSIONS

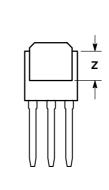
## **3 IPAK, STRAIGHT LEAD**

CASE 369AC-01 **ISSUE O** 



IPAK CASE 369D-01 **ISSUE C** 





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS		
DIM	MIN	MAX	MIN	MAX		
Α	0.235	0.245	5.97	6.35		
В	0.250	0.265	6.35	6.73		
С	0.086	0.094	2.19	2.38		
D	0.027	0.035	0.69	0.88		
Е	0.018	0.023	0.46	0.58		
F	0.037	0.045	0.94	1.14		
G	0.090	BSC	2.29 BSC			
Н	0.034	0.040	0.87	1.01		
J	0.018	0.023	0.46	0.58		
κ	0.350	0.380	8.89	9.65		
R	0.180	0.215	4.45	5.45		
S	0.025	0.040	0.63	1.01		
V	0.035	0.050	0.89	1.27		
Ζ	0.155		3.93			
STYLE 2:						
PIN 1. GATE						
2. DRAIN						

З.

SOURCE DRAIN 4

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NOTES 1.. DIMENSIONING AND TOLERANCING

> к 0.134

4.

**B** 0.250 0.265

E 0.018 0.023

F 0.037 0.043 
 G
 0.090 BSC
 2.29 E

 H
 0.034
 0.040
 0.87

DIMENSION A DOES NOT INCLUDE

DAMBAR POSITION OR MOLD GATE. INCHES

 DIM
 MIN
 MAX
 MIN
 MAX

 A
 0.235
 0.245
 5.97
 6.22

 C
 0.086
 0.094
 2.19
 2.38

 D
 0.027
 0.035
 0.69
 0.88

J 0.018 0.023 0.46 0.58

 R
 0.180
 0.215
 4.57
 5.46

 V
 0.035
 0.050
 0.89
 1.27

**W** 0.000 0.010 0.000 0.25

0.142

MILLIMETERS

0.46 0.58

2.29 BSC 1.01

0.94 1.09

6.73

3.60

6.35

3.40